

Notice of References Cited

Application/Control No.

09/529,762

Applicant(s)/Patent Under
Reexamination
RITTERSHAUS ET AL.

Examiner

" Neon" Phuong Huynh

Art Unit

1644

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 96-39168 A1	12-1996	US	Kwoh et al	
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NON-PATENT DOCUMENTS

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